

TECHNICAL DATA DATASHEET 4099, REV D

# Three-Phase IGBT BRIDGE, With Gate Driver and Optical Isolation

**DESCRIPTION:** A 1200 VOLT, 80 AMP, THREE PHASE IGBT BRIDGE

### **ELECTRICAL CHARACTERISTICS PER IGBT DEVICE**

(Tj=25°C UNLESS OTHERWISE SPECIFIED)

| PARAMETER   |  | SYMBOL               | MIN  | TYP | MAX      | UNIT     |
|---|--|----------------------|------|-----|----------|----------|
| IGBT SPECIFICATIONS   |  |                      |      |     |          |          |
| Collector to Emitter Breakdown Voltage $I_C = 250 \ \mu A, \ V_{GE} = 0V$   |  | BV <sub>CES</sub>    | 1200 | -   | -        | V        |
| Continuous Collector Current  | $T_C = 25$ °C<br>$T_C = 90$ °C                                 | Ic                   | -    | -   | 80<br>70 | А        |
| Pulsed Collector Current, 1mS   |  | I <sub>CM</sub>      | -    | -   | 200      | А        |
| Gate to Emitter Voltage   |  | $V_{GE}$             | -    | -   | +/-20    | V        |
| Gate-Emitter Leakage Current , V <sub>GE</sub> = +/-20V   |  | I <sub>GES</sub>     | -    | -   | +/- 100  | nA       |
| Gate Threshold Voltage, I <sub>C</sub> =2mA   |  | V <sub>GE(TH)</sub>  | 3.0  | -   | 6.0      | V        |
| Zero Gate Voltage Collector Current $V_{CE} = 1200 \text{ V},  V_{GE} = 0V  T_i = 25^{\circ}\text{C}$ $V_{CE} = 900 \text{ V},  V_{GE} = 0V  T_i = 125^{\circ}\text{C}$ |  | I <sub>CES</sub>     | -    | -   | 1 10     | mA<br>mA |
| Collector to Emitter Saturation Voltage, $I_C = 60A$ , $V_{GE} = 15V$ ,   | $T_C = 25$ °C  | V <sub>CE(SAT)</sub> | -    | 2.5 | 2.8      | V        |
| Maximum Thermal Resistance  |  | R <sub>eJC</sub>     | -    | -   | 0.3      | °C/W     |
| Brake IGBT SPECIFICATIONS   |  |                      |      |     |          |          |
| Continuous Collector Current  | $T_{\rm C}$ = 25 $^{\rm O}$ C<br>$T_{\rm C}$ = 90 $^{\rm O}$ C | lc                   | -    | -   | 40<br>25 | А        |
| Pulsed Collector Current, 0.5mS   | <u> </u>   | I <sub>CM</sub>      | -    | -   | 120      | А        |

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| OVER-TEMPERATURE SHUTDOWN  |                   |      |     |      |         |
|--|-------------------|------|-----|------|---------|
| Over-Temperature Shutdown  | Tsd               | 100  | 110 | 120  | °C      |
| Over-Temperature Shutdown Hysteresis   |                   |      | 20  |      | °C      |
| Over-Temperature Output  | Tco               |      | 10  |      | 10mV/°C |
| ULTRAFAST DIODES RATING AND CHARACTERI   | STICS             | 1    |     |      |         |
| Diode Peak Inverse Voltage   | PIV               | 1200 | -   | -    | V       |
| Continuous Forward Current, T <sub>C</sub> = 90 <sup>O</sup> C                   | I <sub>F</sub>    | -    | -   | 60   | А       |
| Forward Surge Current, t <sub>p</sub> = 10 msec                                  | I <sub>FSM</sub>  | -    | -   | 250  | А       |
| Diode Forward Voltage, $I_F = 70A$   | V <sub>F</sub>    | -    | 2.0 | 2.3  | V       |
| Diode Reverse Recovery Time ( $I_F$ =60A, $V_{RR}$ =600V , di/dt=200 A/ $\mu$ s) | t <sub>rr</sub>   | -    | 180 | 250  | nsec    |
| Maximum Thermal Resistance   | R <sub>eJC</sub>  | -    | -   | 0.55 | °C/W    |
| GATE DRIVER  |                   |      |     |      |         |
| Supply Voltage   | VCC               | 10   | 15  | 20   | V       |
| Input On Current   | HIN, LIN          | 2    |     | 5.0  | mA      |
| Opto-Isolator Logic High Input Threshold   | I <sub>th</sub>   | -    | 1.6 | -    | mA      |
| Input Reverse Breakdown Voltage  | BV <sub>in</sub>  | 5.0  | -   | -    | V       |
| Input Forward Voltage @ I <sub>in</sub> = 5mC                                    | V <sub>F</sub>    | -    | 1.5 | 1.7  | V       |
| Under Voltage Lockout  | VCCUV             | 11.5 | -   | 12.5 | V       |
| ITRIP Reference Voltage (1)  | Itrip-ref         | 2.9  | 3.0 | 3.1  | V       |
| Desaturation Over-Current Protection Blanking time (2)                           | tbl               | 3    | 5   | TBD  | μsec    |
| Logic Inputs Fault, Fault Clr, SD Logic "1" Input Voltage                        |                   | 2.0  | -   | -    | V       |
| Logic Inputs Fault, Fault Clr, SD Logic "0" Input Voltage                        |                   | -    | -   | 0.8  | V       |
| Input-to-Output Turn On Delay  | t <sub>ond</sub>  | -    |     | 800  | nsec    |
| Output Turn On Rise Time   | t <sub>r</sub>    | -    |     | 100  |         |
| Input-to-Output Turn Off Delay   | t <sub>offd</sub> | -    |     | 1000 |         |
|  | t <sub>f</sub>    |      |     | 100  |         |
| Output Turn Off Fall Time At VCC=300V, IC=50A, T <sub>C</sub> = 25               |                   |      |     |      |         |
| Input-Output Isolation Voltage   | _                 | 1000 | _   | _    | V       |

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<sup>2</sup> 

### **SENSITRON**

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| Maximum operating Junction Temperature | T <sub>jmax</sub> | -40 | ı | 150 | °C |
|--|-------------------|-----|---|-----|----|
| Maximum Storage Junction Temperature   | T <sub>jmax</sub> | -55 | - | 150 | °C |

# **Pin Description**

| Pin Number | Function                                     | Pin Number | Function  |  |
|------------|--|------------|---|--|
| 1          | Isolated Input for Low-side IGBT of Phase A  | 17         | +15V Rtn (Signal Ground)  |  |
| 2          | Return for Input at 1                        | 18         | Fault Output (3)  |  |
| 3          | Isolated Input for High-side IGBT of Phase A | 19         | Fault Clear Input <sup>(3)</sup>  |  |
| 4          | Return for Input at 3                        | 20         | +5V Output  |  |
| 5          | Isolated Input for Low -side IGBT of Phase B | 21         | Over-Current Trip Set point (3)   |  |
| 6          | Return for Input at 5                        | 22         | DC Bus Current Output with Total Gain of 0.0365 V/A   |  |
| 7          | Isolated Input for High-side IGBT of Phase B | 23         | Case Temperature Output with a gain of 0.010 V/°C   |  |
| 8          | Return for Input at 7                        | 24         | Brake IGBT Gate Input   |  |
| 9          | Isolated Input for Low-side IGBT of Phase C  | 25         | Brake IGBT Emitter Input. This input is internally connected to Signal Ground                     |  |
| 10         | Return for Input at 9                        | 26 to 30   | DC Bus return   |  |
| 11         | Isolated Input for High-side IGBT of Phase C | 31 , 32    | Brake Resistor Terminal. Brake Resistor<br>Shall be Connected Between These<br>Terminals and +VDC |  |
| 12         | Return for Input at 11                       | 33 to 37   | DC Bus "+VDC" input   |  |
| 13         | NC   | 38 to 42   | Phase C output  |  |
| 14         | NC   | 43 to 47   | Phase B output  |  |
| 15         | SD <sup>(3)</sup>                            | 48 to 52   | Phase A output  |  |
| 16         | +15V Input                                   | Case       | Isolated  |  |

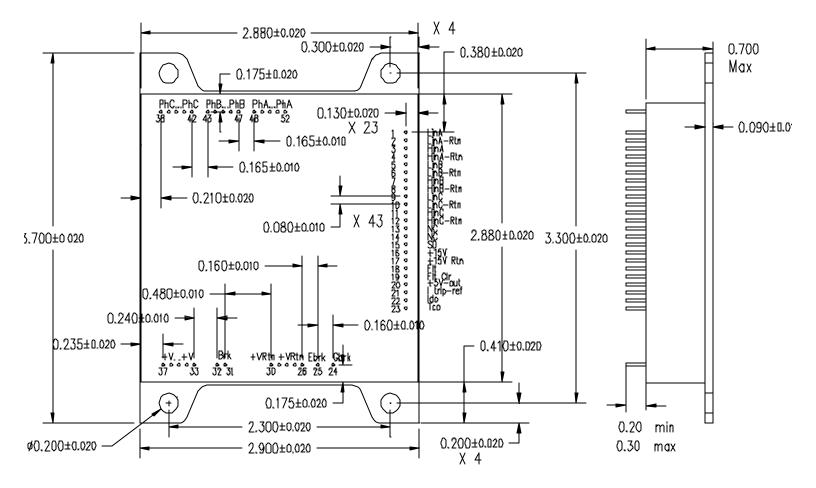
<sup>(1)</sup> ITRIP Cycle-by cycle current limit is internally set to 70A peak. The set point can be lowered by connecting a resistor between Itrip-ref and Gnd. The set point can be increased by connecting a resistor between Itrip-ref and +5V ref

<sup>(2)</sup> Desaturation blanking maximum time is TBD and is only provided at the low-side IGBTs.

<sup>(3)</sup> See application notes on page 6.

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# **Package Drawing:**



#### **SENSITRON**

### **TECHNICAL DATA**

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### **Application Notes:**

### a- Shutdown Feature:

- **1-** SD is a dual function input/output, active low input. It is internally pulled high. As a low input shuts down all IGBTs regardless of the Hin and Lin signals.
- **2-** SD is also internally activated by the over-temperature shutdown, over-current limit, undervoltage shutdown, and desaturation protection.
- **3-** Over-temperature shutdown and over-current limit are not latching features.
- **4-** Under-voltage shutdown is automatically reset after 300 msec once the VCC rises above the threshold limit.
- 5- Desaturation shutdown is a latching feature and internally reset after 300 msec.
- 6- When any of the internal protection features is activated, SD is pulled down.
- **7-** SD can be used to shutdown all IGBTs except the brake IGBT by an external command. An open collector switch shall be used to pull down SD externally.
- 8- Also, SD can be used as a fault condition output. Low output at SD indicates a fault situation.

### b- Fault Output Feature:

- **1-** Pin 18 Flt is a dual function pin. It is internally pulled high. If pulled down, it will freeze the status of all the six IGBTs regardless of the Hin and Lin signals
- **2-** Pin 18 as an output reports desaturation protection activation. When desaturation protection is activated a low output for about 9 µsec is reported.
- **3-** If any other protection feature is activated, it will not be reported by Pin 18.

### c- Fault Clear Output:

- **1-** Pin 19 is a fault clear input. It can be used to reset a latching fault condition, due to desaturation protection.
- **2-** Pin 19 is internally pulled down. A latching fault due to desaturation can be cleared by pulling high this input.
- **3-** An internal fault clear is activated after 300 msec delay. If desired to clear the fault earlier, this input can be used.



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